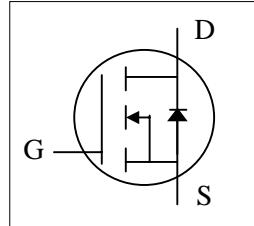
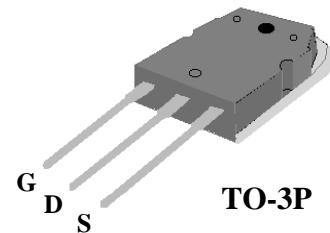




- ▼ Low On-resistance
- ▼ Simple Drive Requirement
- ▼ Fast Switching Characteristic



$BV_{DSS}$	500V
$R_{DS(ON)}$	0.4Ω
$I_D$	16A



## Description

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-3P package is preferred for commercial & industrial applications with higher power level preclusion than TO-220 device.

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	500	V
$V_{GS}$	Gate-Source Voltage	+30	V
$I_D @ T_C=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	16	A
$I_D @ T_C=100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	11	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	60	A
$P_D @ T_C=25^\circ C$	Total Power Dissipation	250	W
$E_{AS}$	Single Pulse Avalanche Energy <sup>3</sup>	72	mJ
$T_{STG}$	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

## Thermal Data

Symbol	Parameter	Value	Units
$R_{thj-c}$	Maximum Thermal Resistance, Junction-case	0.5	°C/W
$R_{thj-a}$	Maximum Thermal Resistance, Junction-ambient	40	°C/W



## Electrical Characteristics@ $T_j=25^\circ C$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=1mA$	500	-	-	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{GS}=10V, I_D=6.5A$	-	-	0.4	$\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2	-	4	V
$g_f$	Forward Transconductance	$V_{DS}=10V, I_D=8A$	-	8	-	S
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=500V, V_{GS}=0V$	-	-	20	$\mu A$
	Drain-Source Leakage Current ( $T_j=125^\circ C$ )	$V_{DS}=500V, V_{GS}=0V$	-	-	200	$\mu A$
$I_{GSS}$	Gate-Source Leakage	$V_{GS}=\pm 30V, V_{DS}=0V$	-	-	$\pm 100$	nA
$Q_g$	Total Gate Charge <sup>2</sup>	$I_D=16A$	-	33	53	nC
$Q_{gs}$	Gate-Source Charge	$V_{DS}=400V$	-	11	-	nC
$Q_{gd}$	Gate-Drain ("Miller") Charge	$V_{GS}=10V$	-	9	-	nC
$t_{d(on)}$	Turn-on Delay Time <sup>3</sup>	$V_{DD}=200V$	-	55	-	ns
$t_r$	Rise Time	$I_D=8A$	-	50	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=50\Omega, V_{GS}=10V$	-	141	-	ns
$t_f$	Fall Time	$R_D=25\Omega$	-	40	-	ns
$C_{iss}$	Input Capacitance	$V_{GS}=0V$	-	1950	3120	pF
$C_{oss}$	Output Capacitance	$V_{DS}=15V$	-	630	-	pF
$C_{rss}$	Reverse Transfer Capacitance	f=1.0MHz	-	20	-	pF

## Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$I_S$	Continuous Source Current ( Body Diode )	$V_D=V_G=0V, V_S=1.3V$	-	-	16	A
$I_{SM}$	Pulsed Source Current ( Body Diode ) <sup>1</sup>		-	-	60	A
$V_{SD}$	Forward On Voltage <sup>2</sup>	$I_S=16A, V_{GS}=0V$	-	-	1.3	V
$t_{rr}$	Reverse Recovery Time <sup>2</sup>	$I_S=16A, V_{GS}=0V$	-	495	-	ns
$Q_{rr}$	Reverse Recovery Charge	dl/dt=100A/ $\mu s$	-	10	-	uC

### Notes:

- 1.Pulse width limited by Max junction temperature.
- 2.Pulse test
- 3.Starting  $T_j=25^\circ C$  ,  $V_{DD}=50V$ ,  $V_{GS}=10V$ ,  $L=1mH$ ,  $R_G=25\Omega$ ,  $I_{AS}=12A$ .

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

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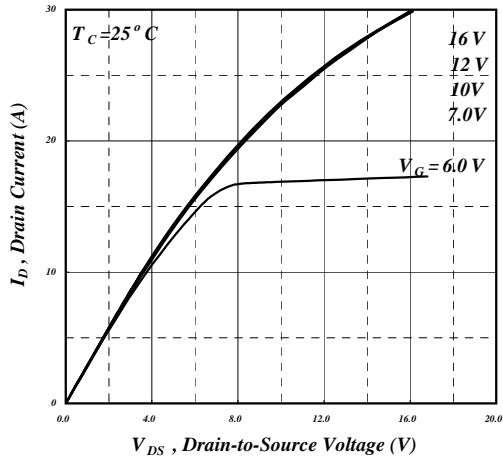


Fig 1. Typical Output Characteristics

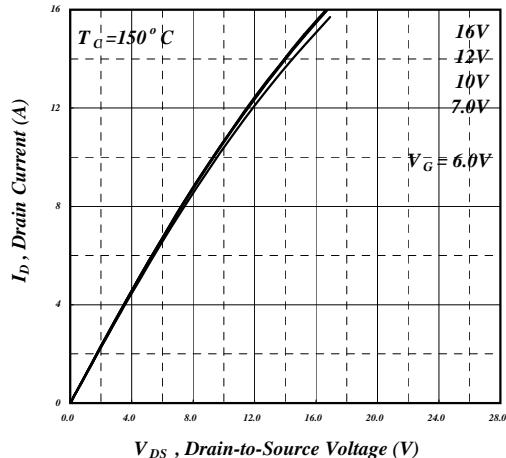


Fig 2. Typical Output Characteristics

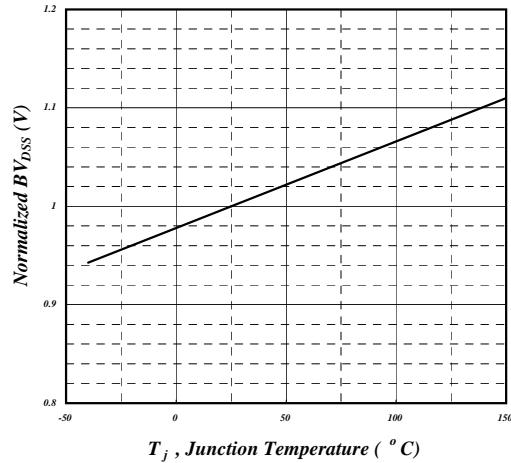
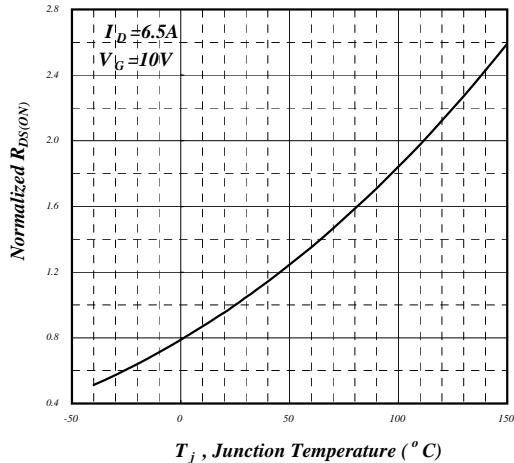
Fig 3. Normalized  $BV_{DSS}$  v.s. Junction Temperature

Fig 4. Normalized On-Resistance v.s. Junction Temperature

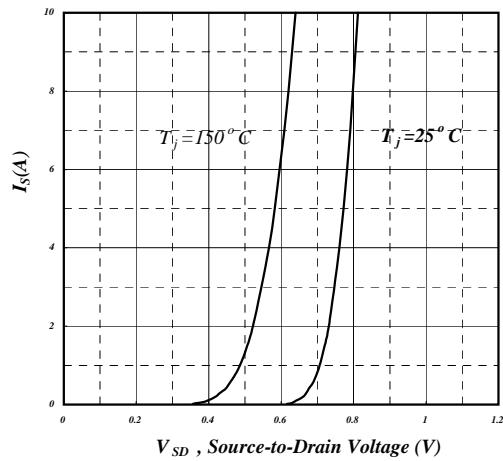


Fig 5. Forward Characteristic of Reverse Diode

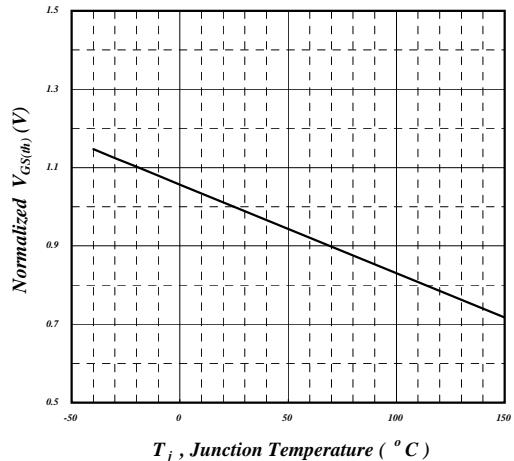
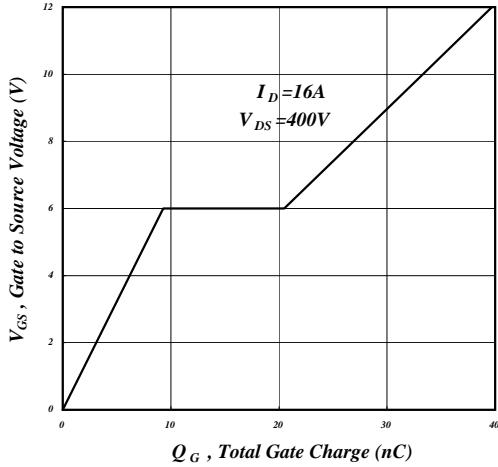
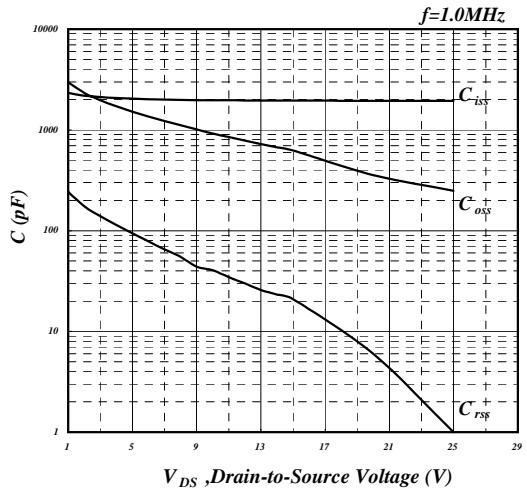


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

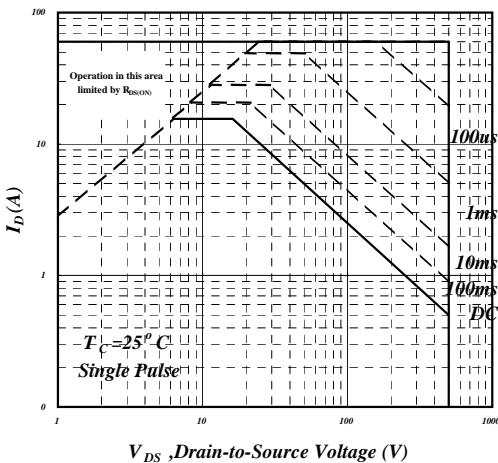
# AP16N50W



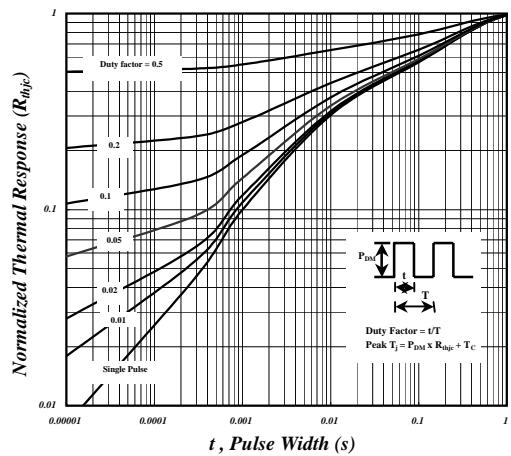
**Fig 7. Gate Charge Characteristics**



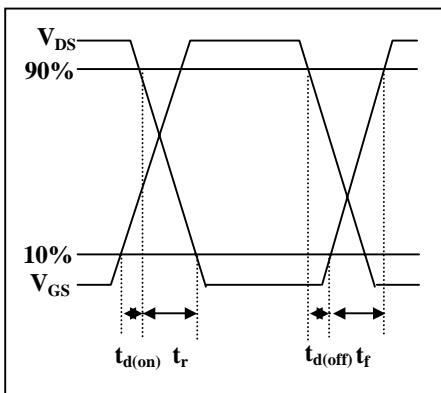
**Fig 8. Typical Capacitance Characteristics**



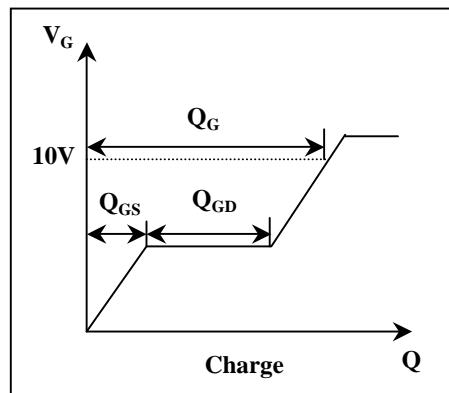
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**



**Fig 11. Switching Time Waveform**



**Fig 12. Gate Charge Waveform**